Search Notes



Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/722,186	KAMASAKI ET AL.	
Examiner	Art Unit	
Jinhee J. Lee	2174	

SEARCHED				
Class	Subclass	Date	Examiner	
715	773	4/15/2007	LEE	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
715	as above	4/15/2007	LEE	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
East text search attached	4/15/2007	LEE
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